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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Attorney Docket No. 050169/0105

In re patent application of Allowed: October 26, 1998
Wallace T.Y. TANG Batch: K83
Serial No. 08/401,229 Group Art Unit: 2874
Filed: March 9, 1995 Examiner: J. Lee

For: IN-SITU REAL-TIME MONITORING TECHNIQUE AND
 APPARATUS FOR ENDPOINT DETECTION OF THIN FILMS
 DURING CHEMICAL/MECHANICAL POLISHING
 PLANARIZATION



SUBMISSION OF FORMAL DRAWINGS

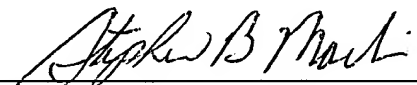
Assistant Commissioner for Patents
Washington, D.C. 20231

Sir:

Applicant submits herewith four sheets of formal
drawings containing Figures 1-6 for this case.

Respectfully submitted,

April 22, 1999
Date


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FIG. 1

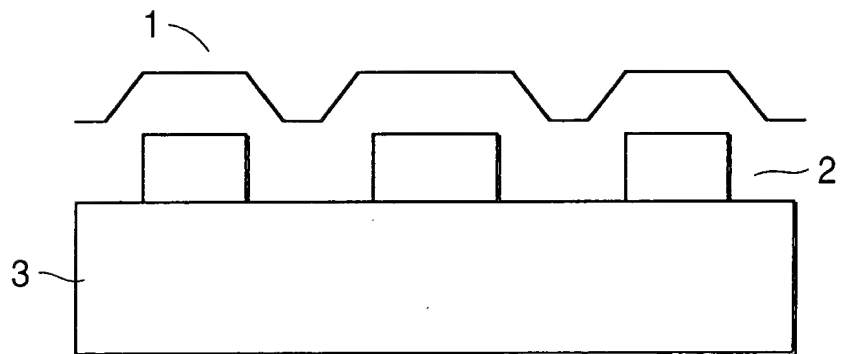


FIG. 2

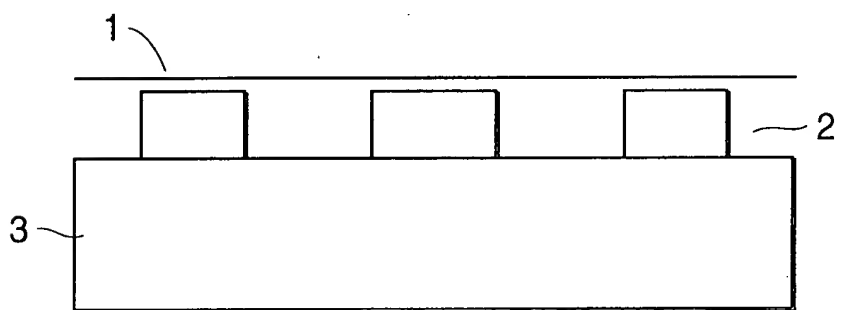


FIG. 3

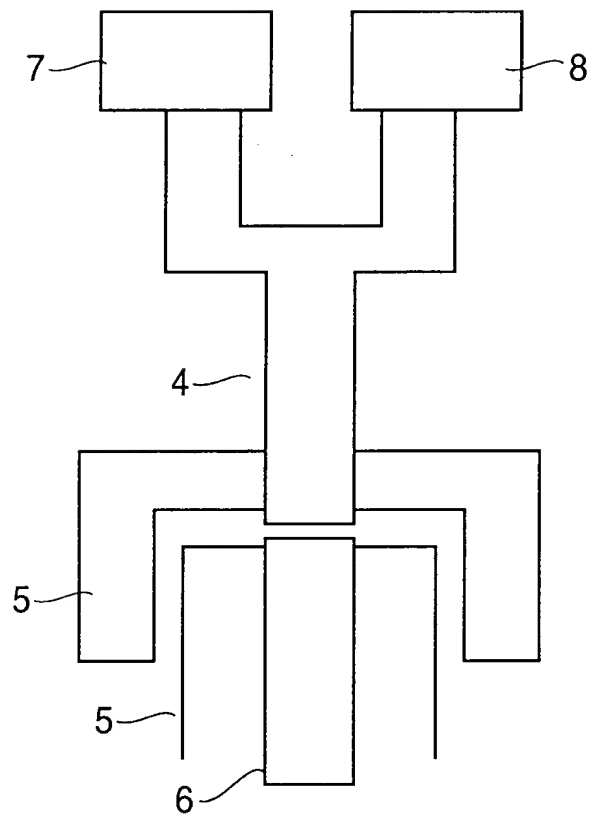


FIG. 4

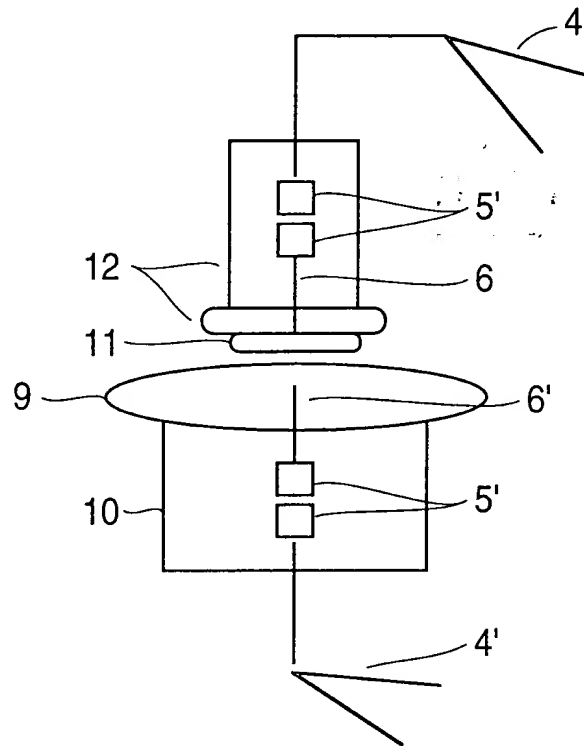


FIG. 5

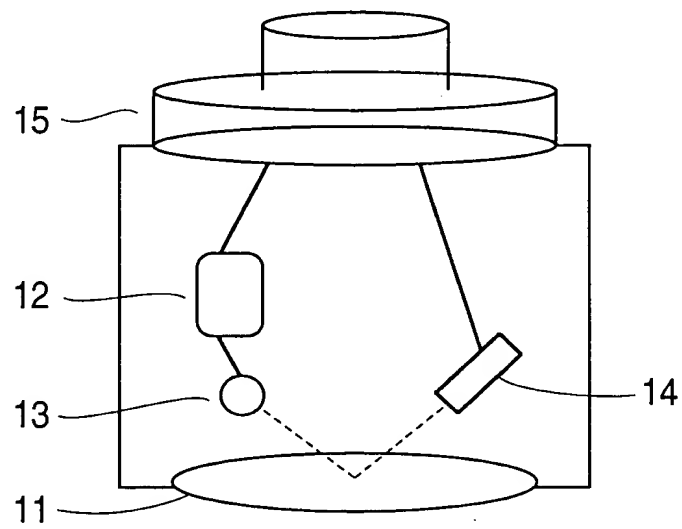


FIG. 6

